Using persistent homology for hypothesis testing

Presentation by Elie Cueto

Articles by Willem Elbers & Rien Van de Weygaert

9/3-23

Journal Articles

Monthly Notices of the ROYAL ASTRONOMICAL SOCIETY

MNRAS **486**, 1523–1538 (2019) Advance Access publication 2019 March 30



doi:10.1093/mnras/stz908

Persistent topology of the reionization bubble network – I. Formalism and phenomenology

Willem Elbers [®] and Rien van de Weygaert Kapteyn Astronomical Institute, University of Groningen, PO Box 800, NL-9700AV Groningen, the Netherlands

Journal Articles

Monthly Notices of the ROYAL ASTRONOMICAL SOCIETY

MNRAS **520**, 2709–2726 (2023) Advance Access publication 2023 January 13



https://doi.org/10.1093/mnras/stad120

Persistent topology of the reionization bubble network – II. Evolution and classification

Willem Elbers^{®1★} and Rien van de Weygaert²

¹Institute for Computational Cosmology, Department of Physics, Durham University, South Road, Durham, DH1 3LE, UK ²Kapteyn Astronomical Institute, University of Groningen, PO Box 800, NL-9700AV Groningen, the Netherlands

Disposition

- Introduction to persistent homology and Persistence diagrams
- Statistical treatment of Persistence diagrams
- Example of use in Astrophysics

Persistent homology: Counting Holes

- Finding the number of n-D holes in a structure.
 - Gaps between components
 - Tunnels through structures
 - Voids within shells
 - Higher dimensional holes



Persistent homology: Counting Holes

Let spheres with a radius alpha surround each point.

Count the number of holes in each dimension as a function of alpha



Persistence diagrams

When is a feature born

When does a feature die

Visualising high dimensional data



Persistence diagrams

When is a feature born When does a feature die

Visualising high dimensional data



Finally: Statistics

We can find the "Distance" between two persistence diagrams:

$$d(X,Y) = \left[\inf_{\phi:X o Y} \sum_{x \in X} ||x - \phi(x)||^2
ight]^{1/2}$$

With Monte Carlo simulations of our New and Improved model, as well as our null hypothesis model we can find a Fréchet Average:

$$F(Y) = \frac{1}{n} \sum_{i=1}^n d(Y, X_i)^2$$

Finally: Statistics

We can find the "Distance" between two persistence diagrams:

$$d(X,Y) = \left[\inf_{\phi:X o Y} \sum_{x \in X} ||x - \phi(x)||^2
ight]^{1/2}$$

With Monte Carlo simulations of our New and Improved model, as well as our null hypothesis model we can find a Fréchet Average:

$$F(Y) = \frac{1}{n} \sum_{i=1}^n d(Y, X_i)^2$$

A model will tend to have a lower Fréchet average, if it is more similar to the data



These persistence diagrams a large distance, as they are constructed from data with different PDFs 9

Distances between diagrams

10

Mock data generated with

$$f(x,y) = (1 + ax + bx^2)(1 + ay + by^2)$$

For a = 1, b = 2.4, -2 < x < 2, N = 1000

The "Correct" PDF gives a much lower distance distribution

1000 simulations with same PDF, Uniform PDF, and PDF with

a = -2, b = 2.4



Persistence Fields

We can find a variance on each feature in our data:

$$\sigma_y^2 = rac{1}{n}\sum_{i=1}^n ||y-\phi_i(y)||^2$$

With the variance we can construct Persistence Fields

For each feature here, $r \sim \sigma$ and "brightness" ~ $(\alpha_{death} - \alpha_{birth})^{0.5}$

11

Highly persistent features tend to be more significant, but less commonly found.

Larger radii here correspond the model being worse at recreating features of data



Persistent homology put to use: Epoch of Reionisation

Distinguishing different models of reionisation.

Even When introducing noise levels consistent with how observations will look, different models can consistently be differentiated



Persistent homology put to use: Epoch of Reionisation

- Distinguishing different models of reionisation.
- Even When introducing noise levels consistent with how observations will look, different models can consistently be differentiated



Conclusions

Visualising High dimensional data

Determining how well different models reproduce data

Very robust to noisy data